



DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

Device	BVDSS	R _{DS(ON)} Max	I _D Max T _C = +25°C
Q1& Q2	30V	11.1m Ω @ V _{GS} = 10V	30A
		15.0m Ω @ V _{GS} = 4.5V	25A

Description

This new generation MOSFET is designed to minimize the on-state resistance (RDS(ON)) yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- General Purpose Interfacing Switch
- Power Management Functions

Features and Benefits

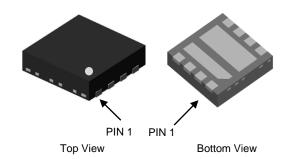
- Ultra Low Gate Threshold Voltage
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative. https://www.diodes.com/quality/product-definitions/

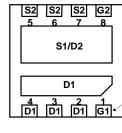
Mechanical Data

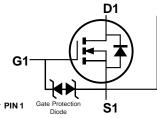
- Case: V-DFN3030-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.02 grams (Approximate)

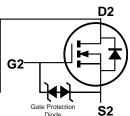


V-DFN3030-8 (Type KS)









Bottom View Internal Schematic

Equivalent Circuit

Ordering Information (Note 4)

Part Number	Case	Tape Width	Tape Pitch	Packaging
DMT3009UDT-7	V-DFN3030-8 (Type KS)	12mm	8mm	1,500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.



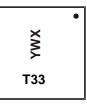
Marking Information

Site 1



T33= Product Type Marking Code
YYWW = Date Code Marking
YY or YY= Last Two Digits of Year (ex: 20 = 2020)
WW = Week Code (01 to 53)

Site 2



T33 = Product Type Marking Code YWX = Date Code Marking Y = Year (ex: H = 2020) W = Week (ex: a = Week 27; z Represents Week 52 and 53) X = Internal Code (ex: U = Monday)

Date Code Key

Year	2019	2020	2021	2022	2023	2024	2025	2026	2027	2028	2029	2030
Code	G	Н	ı	J	K	L	М	N	0	Р	R	S

Week	1-26	27-52	53
Code	A-Z	a-z	Z

Internal Code	Sun	Mon	Tue	Wed	Thu	Fri	Sat
Code	Т	U	V	W	Х	Y	Z



Characteristic	Symbol	Q1&Q2	Unit		
Drain-Source Voltage	VDSS	30	V		
Gate-Source Voltage	Vgss	±12	V		
Continuous Drain Current (Note 6) V _{GS} = 10V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	lo	10.6 8.5	А
Continuous Drain Current (Note 7) V _{GS} = 10V	Steady State	T _C = +25°C T _C = +70°C	lo	30 25	А
Maximum Body Diode Forward Current (Note 6)			Is	2.1	Α
Pulsed Drain Current (100µs Pulse, Duty Cycle = 1%)			lом	80	Α
Pulsed Body Diode Forward Current (100µs Pulse, Du	I _{SM}	80	Α		
Avalanche Current (Note 8) L = 0.1mH	las	19	Α		
Avalanche Energy (Note 8) L = 0.1mH			E _{AS}	18	mJ

Thermal Characteristics ($@T_J = +25^{\circ}C$, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	T _A = +25°C	PD	1.1	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	RθJA	112	°C/W
Total Power Dissipation (Note 6)	T _A = +25°C	PD	1.9	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	Reja	66	°C/W
Total Power Dissipation (Note 7)	Tc = +25°C	PD	16	W
Thermal Resistance, Junction to Case (Note 7)		R _θ JC	8	°C/W
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C

Electrical Characteristics (@T_J = +25°C, unless otherwise specified.)

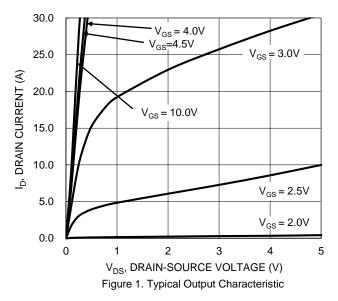
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 9)						
Drain-Source Breakdown Voltage	BV_{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	IDSS	_	_	1	μΑ	V _{DS} = 24V, V _{GS} = 0V
Gate-Source Leakage	Igss	_	_	±10	μΑ	$V_{GS} = \pm 10V$, $V_{DS} = 0V$
ON CHARACTERISTICS (Note 9)						
Gate Threshold Voltage	V _G S(TH)	0.5	_	1.8	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$
Static Drain-Source On-Resistance	Descou	_	8.6	11.1	mΩ	$V_{GS} = 10V, I_D = 11A$
Static Drain-Source On-Resistance	RDS(ON)	_	11.5	15	1115.2	$V_{GS} = 4.5V, I_{D} = 7A$
Diode Forward Voltage	VsD	_	0.8	1.2	V	$V_{GS} = 0V, I_{S} = 8.8A$
DYNAMIC CHARACTERISTICS (Note 10)						
Input Capacitance	Ciss	_	894	_		
Output Capacitance	Coss	_	381	_	pF	$V_{DS} = 15V$, $V_{GS} = 0V$, $f = 1.0MHz$
Reverse Transfer Capacitance	Crss	_	76	_		
Gate Resistance	Rg	_	1.1	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1.0MHz$
Total Gate Charge (V _{GS} = 10V)	Qg	_	14.6	_		
Total Gate Charge (VGS = 4.5V)	Qg	_	7.4	_	nC	\/ 15\/ I- 10A
Gate-Source Charge	Qgs	_	1.6	_	IIC	$V_{DS} = 15V, I_{D} = 10A$
Gate-Drain Charge	Qgd	_	3.4	_		
Turn-On Delay Time	t _{D(ON)}	_	3.4	_		
Turn-On Rise Time	t _R	_	5.5	_		$V_{GS} = 10V, V_{DD} = 15V, R_g = 1\Omega,$
Turn-Off Delay Time	tD(OFF)	_	9.6	_	ns	I _D = 8.8A
Turn-Off Fall Time	t _F	_	1.6	_		
Body Diode Reverse Recovery Time	trr	_	17	_	ns	1 0 0 A divisity 400 A /
Body Diode Reverse Recovery Charge	Qrr	_	6.7	_	nC	IF = 8.8A, di/dt = 100A/µs

Notes:

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.7. Thermal resistance from junction to soldering point (on the exposed drain pad).

- 8. UIS in production with L = 0.1mH, starting $T_A = +25$ °C.
- 9. Short duration pulse test used to minimize self-heating effect.
- 10. Guaranteed by design. Not subject to product testing.





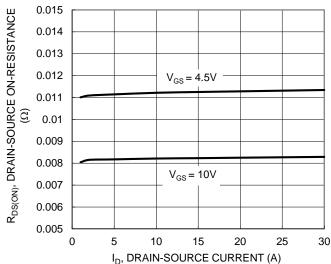


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

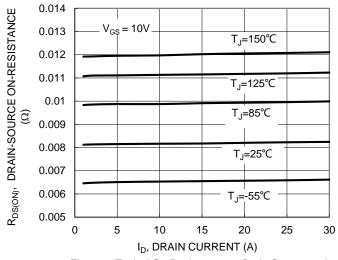


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature

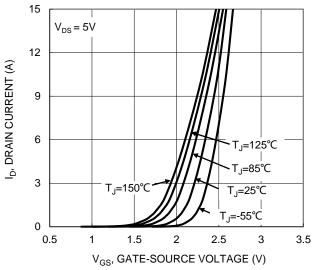


Figure 2. Typical Transfer Characteristic

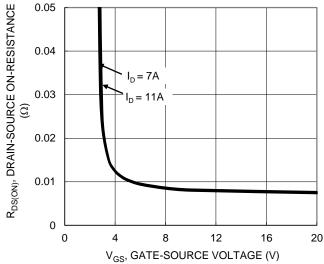


Figure 4. Typical Transfer Characteristic

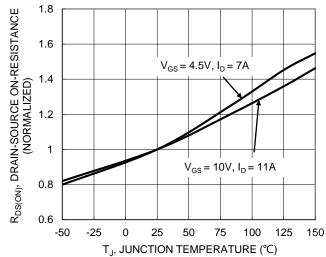


Figure 6. On-Resistance Variation with Junction Temperature



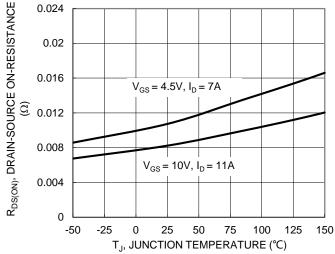


Figure 7. On-Resistance Variation with Junction Temperature

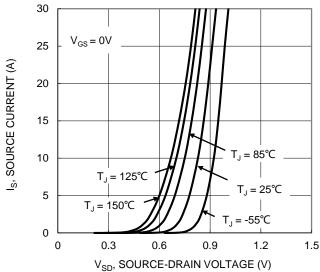


Figure 9. Diode Forward Voltage vs. Current

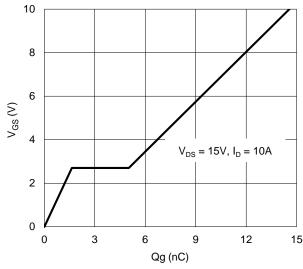


Figure 11. Gate Charge

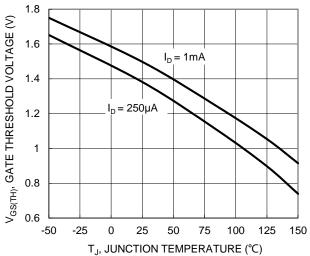


Figure 8. Gate Threshold Variation vs. Junction Temperature

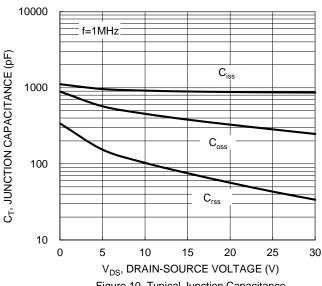
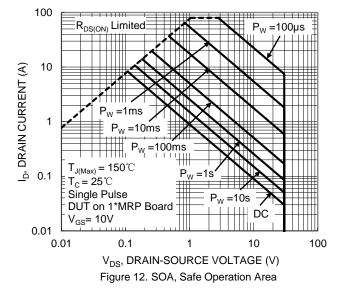


Figure 10. Typical Junction Capacitance





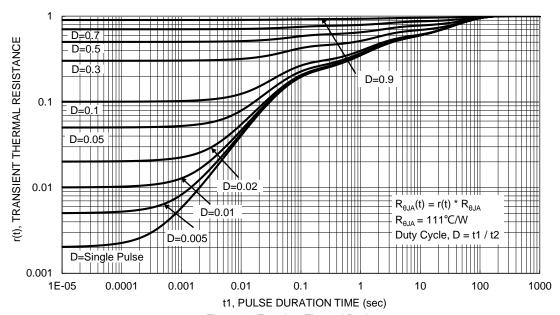


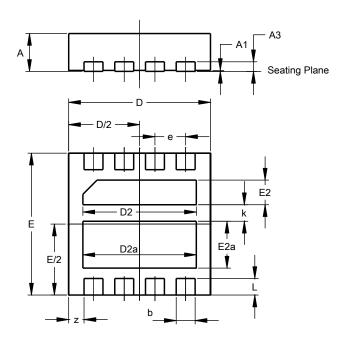
Figure 13. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

V-DFN3030-8 (Type KS)

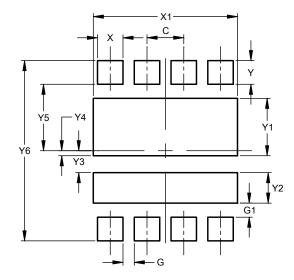


	V-DFN3030-8 (Type KS)						
Dim	Min Max Typ						
Α	0.77	0.85	0.80				
A1	0.00	0.05	0.02				
A3	0.20BSC						
b	0.35 0.45 0.40						
D	2.95	3.050	3.00				
D2	2.30	2.50	2.40				
D2a	2.30	2.50	2.40				
Е	2.95	3.050	3.00				
E2	0.42	0.62	0.52				
E2a	0.89	1.09	0.99				
е	().65BSC	;				
k	-	-	0.35				
L	0.30 0.40		0.35				
Z	z 0.325BSC						
All	Dimensi	ons in	mm				

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

V-DFN3030-8 (Type KS)



Dimensions	Value
פווטופווזטווט	(in mm)
С	0.650
G	0.200
G1	0.250
X	0.450
X1	2.550
Y	0.420
Y1	1.019
Y2	0.541
Y3	0.389
Y4	0.089
Y5	1.180
Y6	3.200



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